	COUNT	DESCRIPTION OF	RIPTION OF REVI		SIONS BY CH		DATE		COUN	IT DES	DESCRIPTION OF REV			BY	CHK	D D	ATE
Δ							Δ										
		L BLE STANDARI						Δ									
AFF	LIOAL	Operating			0-		NE 00 (NI	. 4\		Storage			4.0	00.	0000	· /N ·	۵)
RATING		Temperature Range		-55°C to +105°C (Note1)						Temperature Range			C to	to +60°C (Note3)			
		Operating Humidity Range							Storage Range	torage Humidity 40% to 70% (Note ange					Note3)	)	
		Applicable Connector		DF51K-*(D)S-2C (###)						Voltage	Voltage 250V AC/DC					DC	
		Applicable Cable								Current			AWG 22 : 2A			2A	
		Insulation Diameter		$\phi$ 1.2 $\sim \phi$ 1.45 mm													
SPECIFICATIONS  ITEM TEST METHOD REQUIREMENTS QT																	
		ITEM			TES	ST ME	THOD					REQUIR	EMENT:	<u>s</u>		QT	AT
CONSTRUCTION			<u> </u>														1
Gene	eral Exar	mination	y and by measuring instrument.						Acco	According to drawing.						0	
Marking			Confirmed visually.														0
ELE	CTRI	CAL CHARAC	TERI	STICS	S												
Cont	act Res	istance	20mV MAX, 1mA (DC or 1000Hz).								30 mΩ MAX.						
Milliv	olt Leve	el Method														0	-
			TED	ISTIC													
MECHANICAL CHARACTERISTICS														1			
Mech	nanical (	Operation	30 times insertion and extraction.								ntact re	sistance: 3	0mΩ MAX	(		0	_
(Sn Plating)										②No	②No damage, crack or looseness of parts.						
Meck	nanical (	Operation	50 times insertion and extraction.								①Contact resistance: $30$ m $\Omega$ MAX						
		(Au Plating)								②No	②No damage, crack or looseness of parts.						
Vibra	ation		Frequency 10 to 55 Hz, single amplitude 0.75 mm,							) @\\							
VIDIC	2011									" UNo	①No electrical discontinuity of 1 $\mu$ s.						-
			at 10 cycles for 3 direction.								damage	e, crack or	looseness	of part	s.		
Shoc	:k		Acceleration 490 m/s $^2$ duration of pulse 11 ms at 3							t 3	3						_
			times 1	for 3 di	rection	s.											
EΝ	VIRON	IMENTAL CHA	RAC	TERI	STICS	S											
Damı	p Heat		Exposed at 40 $\pm$ 2 $^{\circ}$ C , humidity 90 to 95 %, 96 h.								$\textcircled{1}$ Contact resistance: 30 m $\Omega$ MAX.						
		(Steady State)	(After leaving the room temperature for 1 to 2h.)							②No	②No damage, crack or looseness of parts.						_
D	. 01		Temperature −55 °C→ +105 °C								100 anto at manistrance 20 mg MAY						+
Rapid Change of											①Contact resistance: 30 mΩ MAX.						
Tem	perature	ı	Time 30min → 30min Under 5 Cycles.								. (2)No damage, crack or looseness of parts.					0	_
(The transferring time of the tank is 2 to 3 MIN)																	
(After leaving the room temperature for 1 to 2h.)																	
Note Note	Remarks  Note 1: Include the temperature rising by current.  Note 2: No condensing  Note 3: Apply to the condition of long term storage for unused products before pcb on board, after pcb board, operating temperature and humidity range is applied for interim storage during transportation.																
					DRAWN				/N	DESIG	DESIGNED C		KED APPROVED		RELEA	ASED	
						J	J.S CHOI		J.S CHOI		S.M.LI	м   т.	S KAN	KANG ENG		G	
							17.12.22		17.12	2.22	17.12.2	22   1	17.12.22		-	20. 02. 13 DEPT	
		vise specified, refer to								<u>                                     </u>							/
NOT	E QT:	QUALIFICATION	TEST	AT: AS	SSURA	NCE TE	EST O:	APPL	ICABL	E TEST		T NO					
	HIRC	SE KOREA CO	.,LTD.	LTD. SPECIFICA				TIOI	N SH	IEET	PAR	PART NO.  DF51K-22SCF (800)					
COD	E NO.(OL			DRAWING NO.				CODE				652_00 <i>0</i>	1				
CL				ELC4-611493					CL 6652-0039-4-800								